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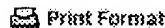
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2 Generalized small-signal dynamical modeling of multi-port DC-DC converters

Hamill, D.C.;

Power Electronics Specialists Conference, 1997. PESC '97 Record., 28th Annual

IEEE , Volume: 1 , 22-27 June 1997

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3 MOVIE: a building block for the design of real time simulator of moving pictures compression algorithms

Barzic, R.; Bouville, C.; Charot, F.; Le Fol, G.; Lemonnier, P.; Wagner, C.;

Application Specific Array Processors, 1995. Proceedings., International Conference on , 24-26 July 1995

Pages:193 - 203

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4 Simultaneous bidirectional signalling for IC systems

Lam, K.; Dennison, L.R.; Dally, W.J.;

Computer Design: VLSI in Computers and Processors, 1990. ICCD '90.

Proceedings., 1990 IEEE International Conference on , 17-19 Sept. 1990

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5 Signal integrity analysis of high-speed, high-pin-count digital packages*Tsai, C.-T.;*

Electronic Components and Technology Conference, 1990. Proceedings., 40th , 20-23 May 1990

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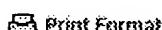
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6560757 72
6463567 60
5655109 50
6446240 50
5995740 50
6053949 50
6467068 50
5706476 49
6141631 48
5883809 48
5978574 48
5479355 48
5544071 48
5812416 48
5903475 48
6339751 48
6591403 48
6266630 47
6237126 45
5426591 44
5764525 44
6539520 44
6389379 44
6421251 44
6438731 44
6678644 44
6104588 43
6172634 43
4556955 43
4907230 43
5991522 43
6067651 43
5484345 43
6216252 41
6216252 41
6061283 41
4939446 39
RE35644 39
5812077 39
5572437 39
5841967 39
6058492 39
5933356 39
6006028 39
6135647 39
6209120 39
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09692297 QUAL

5487018 39
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2 716/3
2 716/4

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7 716/18
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5 716/6
5 716/8
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2 703/2
2 716/10
2 716/12
2 716/7
2 717/106

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11 703/14
11 716/18
8 703/15
8 716/6
7 716/5
5 703/13
5 716/2
5 716/8
3 703/20
3 714/33
3 716/1
3 716/3

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3 716/4
2 324/627
2 324/72
2 703/16
2 703/19
2 703/2
2 714/738
2 716/10
2 716/11
2 716/12
2 716/7
2 717/106